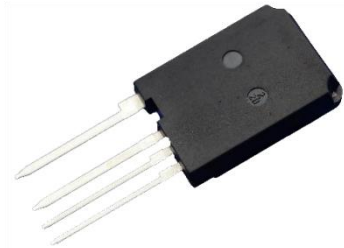
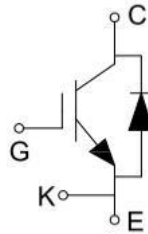


**Trench Field-stop IGBT Discrete**

Parameter	Value	Unit
$V_{CE}$	1200	V
$I_C$	180	A
$V_{CE(sat)}$	1.66	V



TO-247PLUS-4L

**Features**

- 1200V trench gate/field termination process
- Low switching losses
- $V_{cesat}$  has a positive temperature coefficient

**Applications**

- Energy storage inverter
- Uninterruptible power supplies
- Solar inverters

**IGBT**
**Maximum Ratings**

Parameter	Symbol	Test condition	Value	Unit
Collector-Emitter voltage	$V_{CES}$	$T_{vj}=25^{\circ}C$	1200	V
Continuous DC collector current	$I_{C\ nom}$	$T_C=100^{\circ}C, T_{vj\ max}=175^{\circ}C$	180	A
Repetitive peak collector current	$I_{CRM}$	$t_p=1ms$	540	A
Gate-emitter voltage	$V_{GE}$		$\pm 20$	V
Transient gate-emitter voltage	$V_{GE}$	$t_p \leq 0.5\mu s, D < 0.001$	$\pm 25$	V
Power dissipation	$P_{tot}$	$T_C=100^{\circ}C$	1200	W
Temperature under switching conditions	$T_{vj\ op}$		-40...+175	$^{\circ}C$
Storage temperature	$T_{stg}$		-40...+150	$^{\circ}C$

**Thermal Characteristics**

Parameter	Symbol	Test condition	Value	Unit
IGBT thermal resistance, junction - case	$R_{th(j-c)}$		0.061	$^{\circ}C/W$
Diode thermal resistance, junction - case	$R_{th(j-c)}$		0.123	$^{\circ}C/W$

**Characteristic Values**

Parameter	Symbol	Test condition	Value			Unit
			Min.	Typ.	Max.	
Collector-Emitter saturation voltage	$V_{CEsat}$	$V_{GE}=15V, I_C=180A$ $V_{GE}=15V, I_C=180A$		1.66 2.10	2.10	V
Gate-Emitter threshold voltage	$V_{GE(th)}$	$I_C=2.4mA, V_{GE}=V_{CE}$	4.3	4.9	5.5	V
Transconductance	$G_{fs}$	$V_{CE}=20V, I_C=180A$		270		S
Internal gate resistor	$R_{Gint}$			3.3		$\Omega$
Input capacitance	$C_{ies}$	$f=100kHz, V_{CE}=25V, V_{GE}=0V$		21.7		nF
Output capacitance	$C_{oes}$			0.42		nF

Reverse transfer capacitance	$C_{res}$			0.09	nF
Gate charge	$Q_G$	$I_C=180A, V_{GE}=15V,$ $V_{CE}=960V$	$T_{vj}=25^\circ C$	1.34	$\mu C$
Collector-emitter cut-off current	$I_{CES}$	$V_{CE}=1200V, V_{GE}=0V$	$T_{vj}=25^\circ C$	100	$\mu A$
Gate-emitter leakage current	$I_{GES}$	$V_{CE}=0V, V_{GE}=20V$	$T_{vj}=25^\circ C$	100	nA
Turn-on delay time	$t_{d(on)}$	$I_C=180A, V_{CE}=600V$ $V_{GE}=\pm 15V,$ $R_{Gon}=5\Omega, R_{Goff}=25\Omega$ (inductive load)	$T_{vj}=25^\circ C$ $T_{vj}=175^\circ C$	116 143	ns
Rise time	$t_r$	$I_C=180A, V_{CE}=600V$ $V_{GE}=\pm 15V,$ $R_{Gon}=5\Omega, R_{Goff}=25\Omega$ (inductive load)	$T_{vj}=25^\circ C$ $T_{vj}=175^\circ C$	86 84	ns
Turn-off delay time	$t_{d(off)}$	$I_C=180A, V_{CE}=600V$ $V_{GE}=\pm 15V,$ $R_{Gon}=5\Omega, R_{Goff}=25\Omega$ (inductive load)	$T_{vj}=25^\circ C$ $T_{vj}=175^\circ C$	680 740	ns
Fall time	$t_f$	$I_C=180A, V_{CE}=600V$ $V_{GE}=\pm 15V,$ $R_{Gon}=5\Omega, R_{Goff}=25\Omega$ (inductive load)	$T_{vj}=25^\circ C$ $T_{vj}=175^\circ C$	93 190	ns
Turn-on energy loss per pulse	$E_{on}$	$I_C=180A, V_{CE}=600V$ $V_{GE}=\pm 15V, R_{Gon}=5\Omega$ $di/dt=1700A/\mu s (T_{vj}=175^\circ C)$ (inductive load)	$T_{vj}=25^\circ C$ $T_{vj}=175^\circ C$	12.3 17.5	mJ
Turn-off energy loss per pulse	$E_{off}$	$I_C=180A, V_{CE}=600V$ $V_{GE}=\pm 15V, R_{Goff}=25\Omega$ $dv/dt=6400V/\mu s (T_{vj}=175^\circ C)$ (inductive load)	$T_{vj}=25^\circ C$ $T_{vj}=175^\circ C$	9.22 13.7	mJ

## Diode

### Maximum Ratings

Parameter	Symbol	Test condition	Value	Unit
Repetitive peak reverse voltage	$V_{RRM}$	$T_{vj}=25^\circ C$	1200	V
Continuous DC forward current	$I_F$	$T_C=100^\circ C, T_{vj,max}=175^\circ C$	180	A
Repetitive peak forward current	$I_{FRM}$	$t_p=1ms$	540	A

### Characteristic Values

Parameter	Symbol	Test condition	Value			Unit
			Min.	Typ.	Max.	
Forward voltage	$V_F$	$I_F=180A, V_{GE}=0V$ $I_F=180A, V_{GE}=0V$	$T_{vj}=25^\circ C$ $T_{vj}=175^\circ C$	2.87 2.63	3.40	V
Peak reverse recovery current	$I_{RM}$	$I_F=180A,$ $-di_F/dt=1460A/\mu s (T_{vj}=175^\circ C)$ $V_R=600V, V_{GE}=-15V$	$T_{vj}=25^\circ C$ $T_{vj}=175^\circ C$	49 88		A
Reverse Recovered charge	$Q_{rr}$	$I_F=180A,$ $-di_F/dt=1460A/\mu s (T_{vj}=175^\circ C)$ $V_R=600V, V_{GE}=-15V$	$T_{vj}=25^\circ C$ $T_{vj}=175^\circ C$	8.30 22.6		$\mu C$
Reverse Recovery Time	$t_{rr}$	$I_F=180A,$ $-di_F/dt=1460A/\mu s (T_{vj}=175^\circ C)$ $V_R=600V, V_{GE}=-15V$	$T_{vj}=25^\circ C$ $T_{vj}=175^\circ C$	387 634		ns
Reverse recovered energy	$E_{rec}$	$I_F=180A,$ $-di_F/dt=1460A/\mu s (T_{vj}=175^\circ C)$ $V_R=600V, V_{GE}=-15V$	$T_{vj}=25^\circ C$ $T_{vj}=175^\circ C$	3.74 10.2		mJ

**Typical Characteristics**

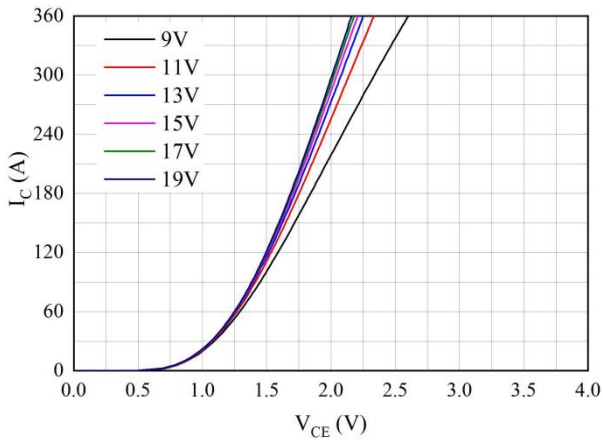


Fig 1. Typical output characteristics ( $T_{vj}=25^{\circ}\text{C}$ )

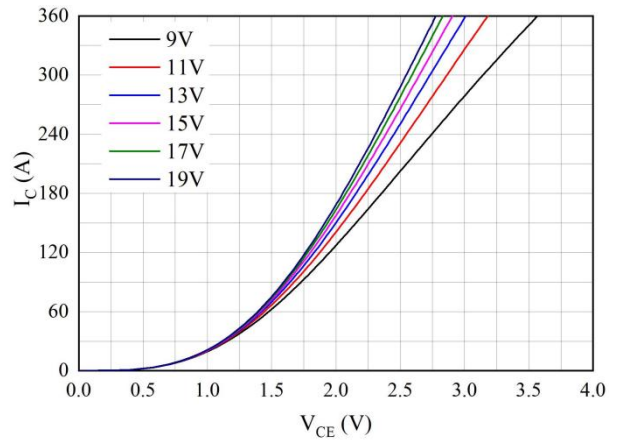


Fig 2. Typical output characteristics ( $T_{vj}=175^{\circ}\text{C}$ )

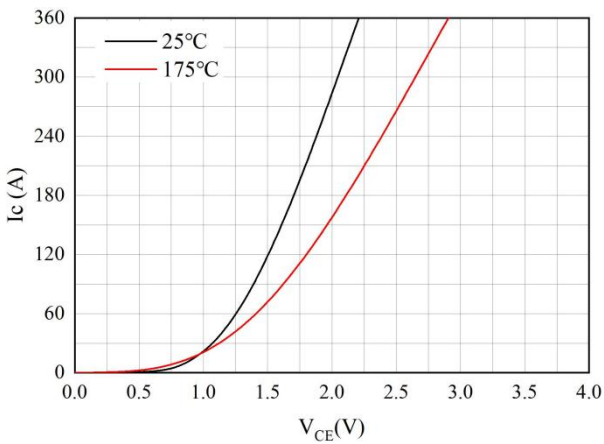


Fig 3. Typical output characteristics ( $V_{ge}=15\text{V}$ )

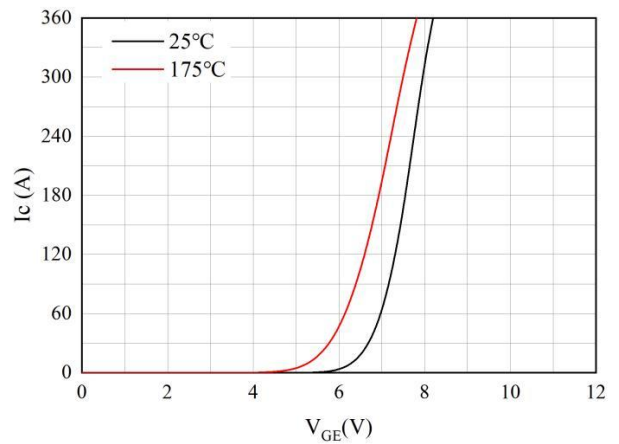


Fig 4. Typical transfer characteristic ( $V_{ce}=20\text{V}$ )

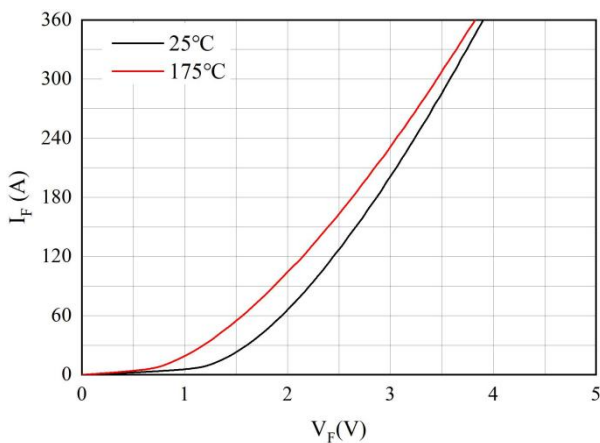


Fig 5. Forward characteristic of Diode

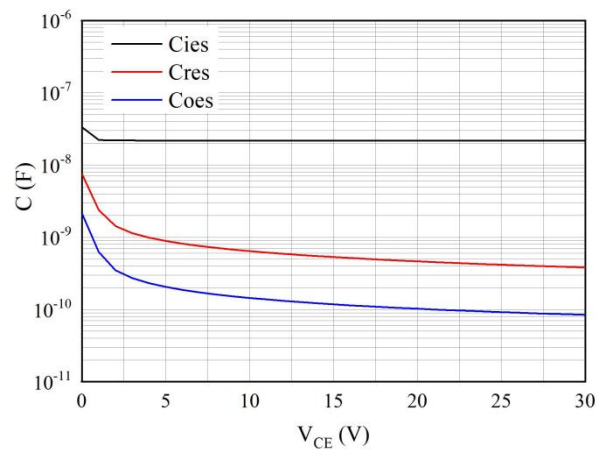


Fig 6. Capacitance characteristic

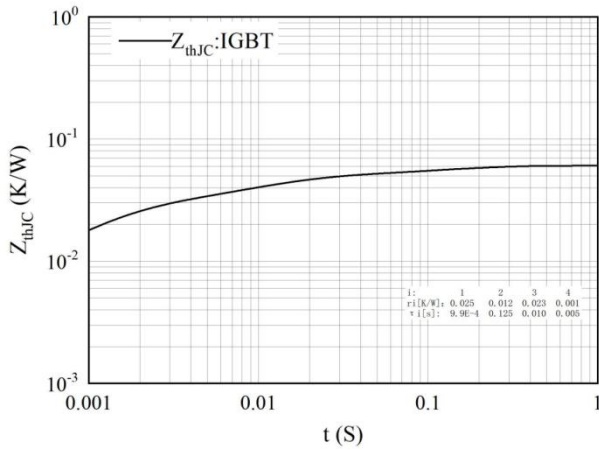


Fig 7. Transient thermal impedance IGBT,  $Z_{thJC}=f(t)$

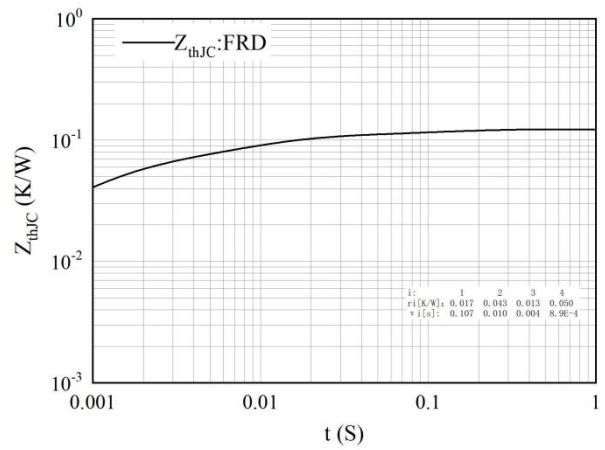


Fig 8. Transient thermal impedance FRD,  $Z_{thJC}=f(t)$

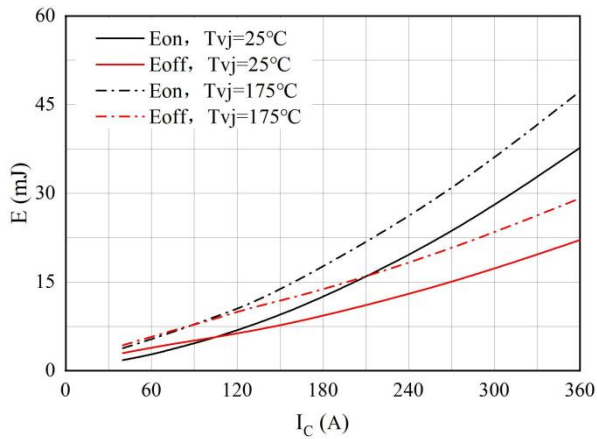


Fig 9. Switching losses of IGBT  
 $V_{GE}=\pm 15V, R_{gon}=5\Omega, R_{goff}=25\Omega, V_{CE}=600V$

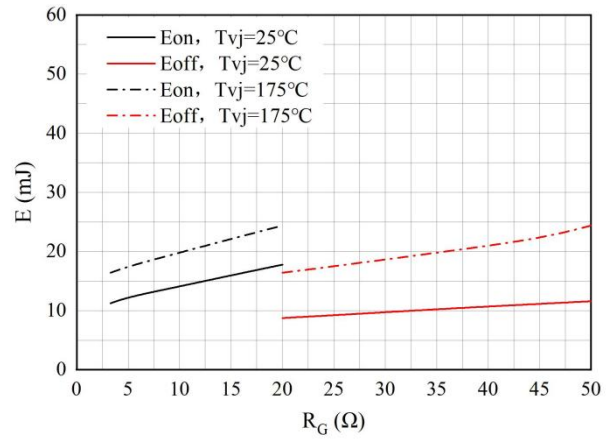


Fig 10. Switching losses of IGBT  
 $V_{GE}=\pm 15V, I_c=180A, V_{CE}=600V$

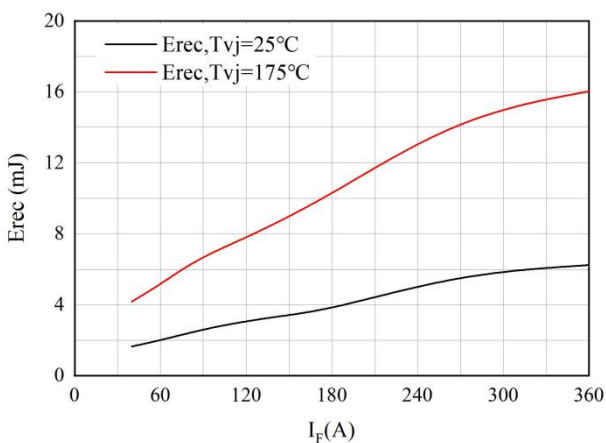


Fig 11. Switching losses of Diode  
 $R_{gon}=5\Omega, V_{CE}=600V$

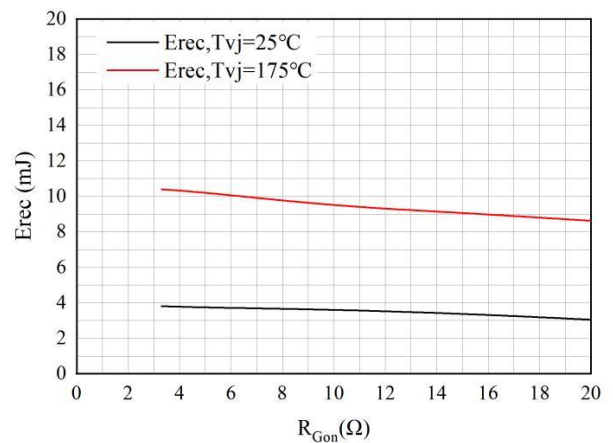
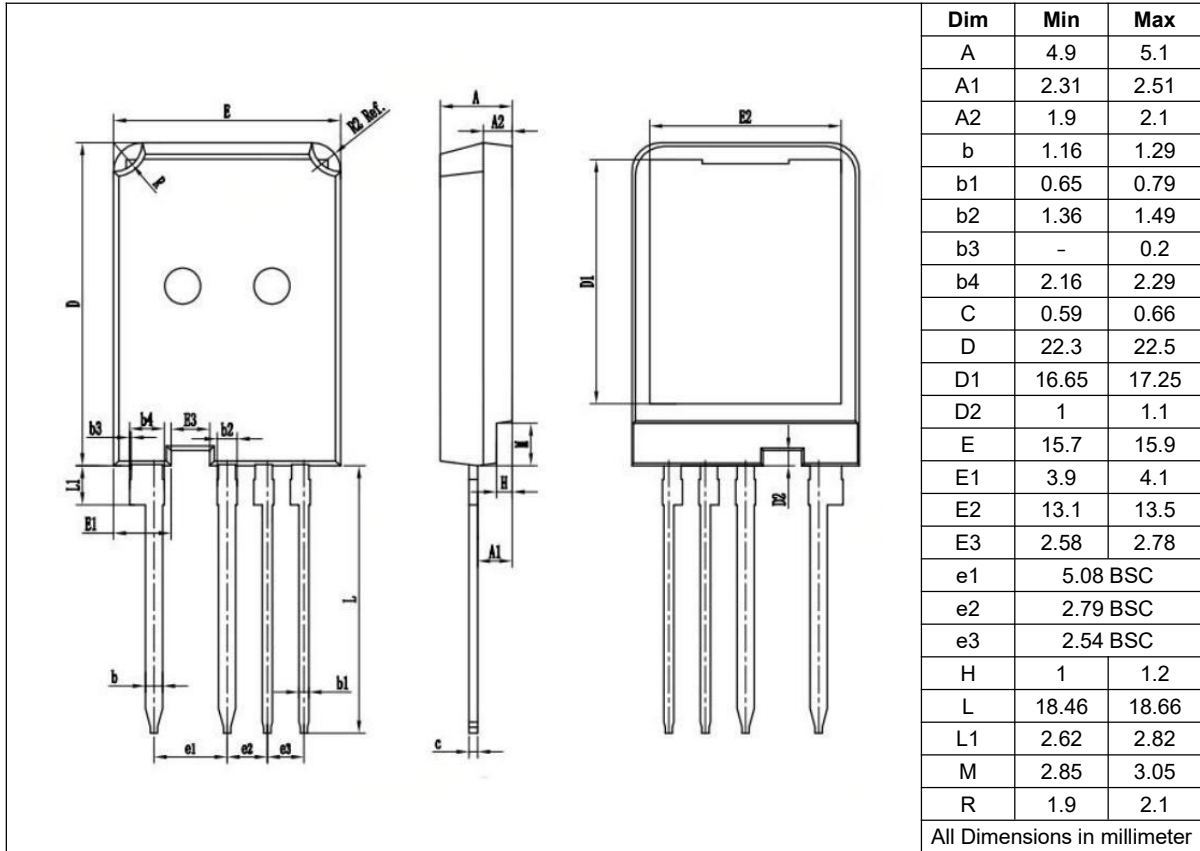


Fig 12. Switching losses of Diode  
 $I_F=180A, V_{CE}=600V$

**Package Outline (Unit: mm)**

**TO-247PLUS-4L**



**\*Important Usage Information and Disclaimer**

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